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Leaders in diagnostic services for microelectronics and photonics

Nitronex NPT35015 GaN HEMT Teardown and Technology Analysis

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1. Product Identification

Manufacturer	Device ID	Date/lot code
Nitronex	NPT35015	063311

2. External Appearance and Principal Dimensions

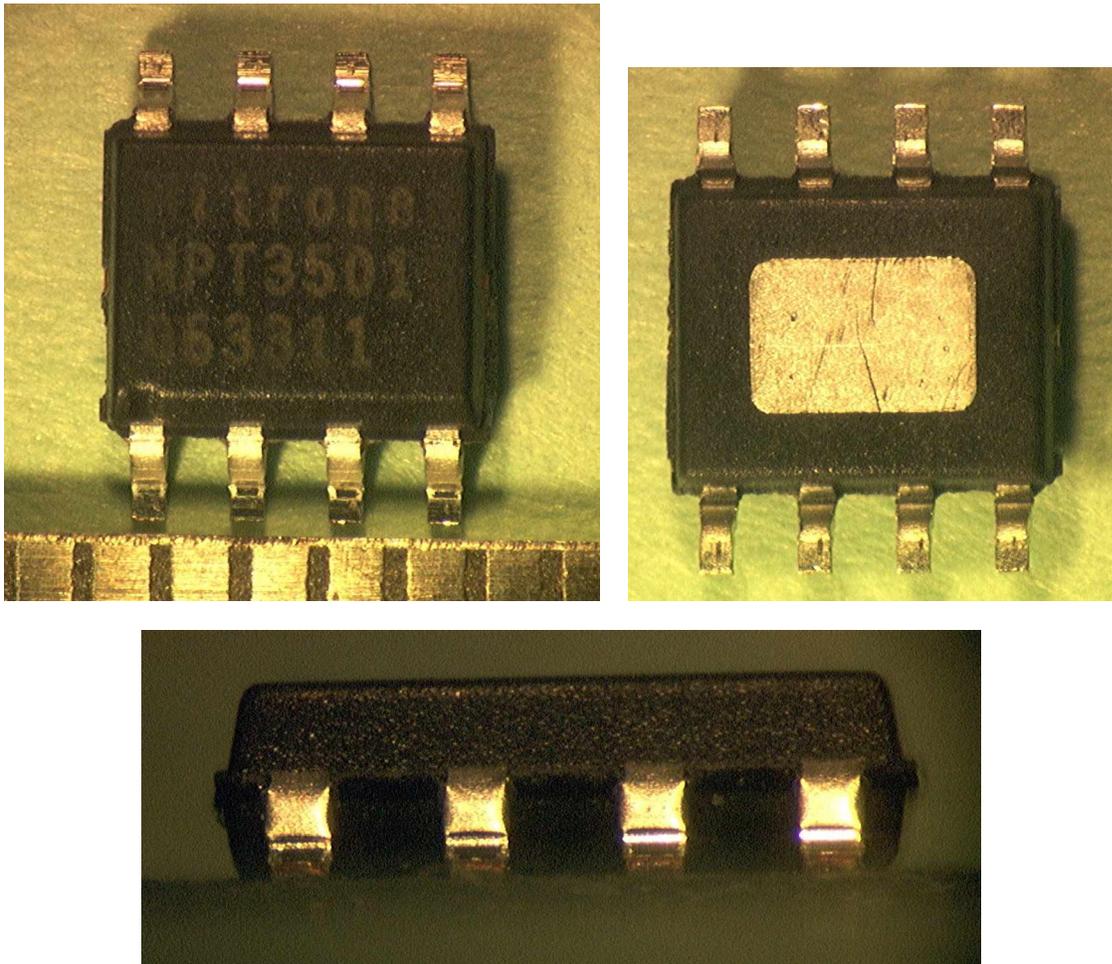


Figure 2.1: Devices as received. The markings of the ruler are 1mm apart.

To purchase the full report, or to request further analyses on this product, please contact sales@muanalysis.com or call 1-613-721-4664

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